

Search Notes**Application/Control No.**

09/518,937

Examiner

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Applicant(s)/Patent under Reexamination

DIVAKARAN ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	8/6/2005	MK
Updated	Search	12/22/2005	MK
Updated	Search	11/28/2006	MK
Updated	Search	7/11/2007	MK
Updated	Search	1/2/2008	MK
Updated	Search	1/4/2008	MK
715	723	1/4/2008	MK
382	190 232	1/4/2008	MK
345	440	1/4/2008	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	501.1 723	1/4/2008	MK
382	190 232	1/4/2008	MK
345	440	1/4/2008	MK
USPAT -- USPGPub		1/4/2008	MK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout I	8/6/2005	MK
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout I	2/22/2005	MK
NPL (ACM, IEEE) See Search History Printout	7/11/2007	MK
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	7/11/2007	MK
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	1/2/2008	MK
Consulted with Primary William Bashore	1/3/2008	MK
West Updated (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	1/4/2008	MK
Interference Search	1/4/2008	MK